 Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/785,598	LEE ET AL.	
Examiner	Art Unit	
Jacob Y. Choi	2875	

:	SEAR	CHED	
Class	Subclass	Date	Examiner
362	328, 330, 26, 311, 606, 609	9/27/2005	1C
362	610	9/27/2005	JC
359	64, 65	9/27/2005	JC

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Class/Subclass Search	9/27/2005	JC
Text Search Conducted by Examiner	9/27/2005	JC
Updated Class/Subclass & Text Search Conducted by Examiner	2/9/2006	JC
Updated Class/Subclass & Text Search Conducted by Examiner	6/13/2006	JC